


<b>Search Notes</b> 	<b>Application/Control No.</b> 10067304	<b>Applicant(s)/Patent Under Reexamination</b> FUJII ET AL.
	<b>Examiner</b> Ba Huynh	<b>Art Unit</b> 2179

SEARCHED			
Class	Subclass	Date	Examiner
715	748,751,753,756-758	11/21/09	hb

SEARCH NOTES		
Search Notes	Date	Examiner
East searched	10/15/2004	hb
East searched	8/07/2005	hb
East search	6/4/2006	hb

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
715	748, 751, 753, 756-758	11/21/09	hb

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